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SERIAL NUMBER 09/891,693	FILING DATE 06/26/2001 RULE	CLASS 356	GROUP ART UNIT 2877	ATTORNEY DOCKET NO. M-10693 US
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APPLICANTS

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** CONTINUING DATA ***** *yes*

This application is a CIP of 09/746,141 12/21/2000 PAT 6,639,662
 which is a CON of 08/933,771 09/19/1997 PAT 6,201,601

** FOREIGN APPLICATIONS ***** *none*

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 08/17/2001

Foreign Priority claimed 35 USC 119 (a-d) conditions met	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after <i>Allowance</i>	STATE OR COUNTRY CA	SHEETS DRAWING 3	TOTAL CLAIMS 45	INDEPENDENT CLAIMS 4
Verified and Acknowledged	Examiner's Signature <i>[Signature]</i>	Initials			

ADDRESS

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TITLE

Systems and methods for a wafer inspection system using multiple angles and multiple wavelength illumination

FILING FEE	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time)
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